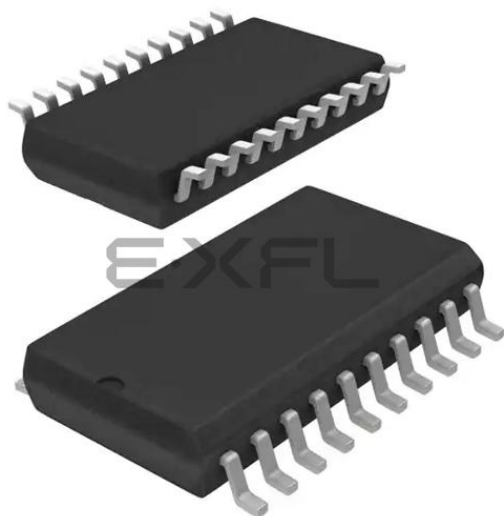




Welcome to [E-XFL.COM](https://www.e-xfl.com)

What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Obsolete
Core Processor	HC08
Core Size	8-Bit
Speed	6MHz
Connectivity	SCI, USB
Peripherals	LED, LVD, POR, PWM
Number of I/O	13
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	384 x 8
Voltage - Supply (Vcc/Vdd)	4V ~ 5.5V
Data Converters	-
Oscillator Type	Internal
Operating Temperature	0°C ~ 70°C (TA)
Mounting Type	Surface Mount
Package / Case	20-SOIC (0.295", 7.50mm Width)
Supplier Device Package	20-SOIC
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mc68hc908jb16jdw

12.8.1	TxD (Transmit Data)	228
12.8.2	RxD (Receive Data)	228
12.9	I/O Registers	229
12.9.1	SCI Control Register 1	229
12.9.2	SCI Control Register 2	232
12.9.3	SCI Control Register 3	235
12.9.4	SCI Status Register 1	238
12.9.5	SCI Status Register 2	242
12.9.6	SCI Data Register	243
12.9.7	SCI Baud Rate Register	244

Section 13. Clock Generator Module (CGM)

13.1	Contents	247
13.2	Introduction	248
13.3	Functional Description	249
13.3.1	Reference Frequency Source (OSCXCLK)	250
13.3.2	Voltage Controlled Oscillator	250
13.3.3	Reference Divider	251
13.3.4	VCO Frequency Divider	251
13.3.5	Phase Detector	251
13.3.6	Phase Detector Filter	251
13.3.7	Lock Detector	251
13.4	I/O Signals	252
13.4.1	CGM Power Supply Pins (V_{DDA} , V_{SSA0} , V_{SSA1})	252
13.4.2	CGM1 Voltage Regulator Out (V_{REGA0})	252
13.4.3	CGM2 Voltage Regulator In (V_{REGA1})	252
13.4.4	External Filter Capacitor Pins (CGMXFC1, CGMXFC2)	253
13.4.5	CGM Clock Output Pins (CGMOUT1, CGMOUT2)	253
13.5	CGMXFC External Connections	253
13.6	CGMOUT External Connections	254
13.7	Calculation of VCO Frequency	254
13.8	Programming the PLL	255
13.9	CGM I/O Registers	255

19.3	Features	308
19.4	Functional Description	308
19.4.1	Flag Protection During Break Interrupts	310
19.4.2	CPU During Break Interrupts	310
19.4.3	TIM During Break Interrupts	310
19.4.4	COP During Break Interrupts	310
19.5	Low-Power Modes	310
19.5.1	Wait Mode	310
19.5.2	Stop Mode	311
19.6	Break Module Registers	311
19.6.1	Break Status and Control Register	311
19.6.2	Break Address Registers	312
19.6.3	SIM Break Status Register	312
19.6.4	SIM Break Flag Control Register	314

Section 20. Electrical Specifications

20.1	Contents	315
20.2	Introduction	316
20.3	Absolute Maximum Ratings	316
20.4	Functional Operating Range	317
20.5	Thermal Characteristics	317
20.6	DC Electrical Characteristics	318
20.7	Control Timing	319
20.8	Oscillator Characteristics	319
20.9	Timer Interface Module Characteristics	320
20.10	USB DC Electrical Characteristics	320
20.11	USB Low-Speed Source Electrical Characteristics	321
20.12	USB Signaling Levels	322
20.13	CGM Electrical Characteristics	322
20.14	FLASH Memory Characteristics	324

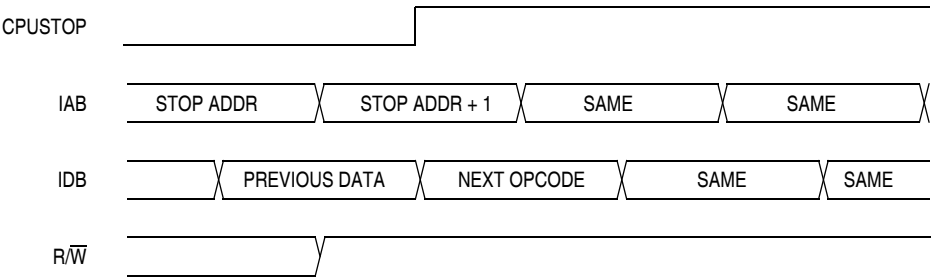
The SIM disables the oscillator signals (OSCOOUT and OSCDCLK) in stop mode, stopping the CPU and peripherals. Stop recovery time is selectable using the SSREC bit in the configuration register (CONFIG). If SSREC is set, stop recovery is reduced from the normal delay of 4096 OSCDCLK cycles down to 2048. This is ideal for applications using canned oscillators that do not require long startup times from stop mode.

NOTE: *External crystal applications should use the full stop recovery time by clearing the SSREC bit.*

A break interrupt during stop mode sets the SIM break stop/wait bit (SBSW) in the SIM break status register (SBSR).

The SIM counter is held in reset from the execution of the STOP instruction until the beginning of stop recovery. It is then used to time the recovery period. **Figure 8-17** shows stop mode entry timing.

NOTE: *To minimize stop current, all pins configured as inputs should be driven to a logic 1 or logic 0.*



NOTE: Previous data can be operand data or the STOP opcode, depending on the last instruction

Figure 8-17. Stop Mode Entry Timing

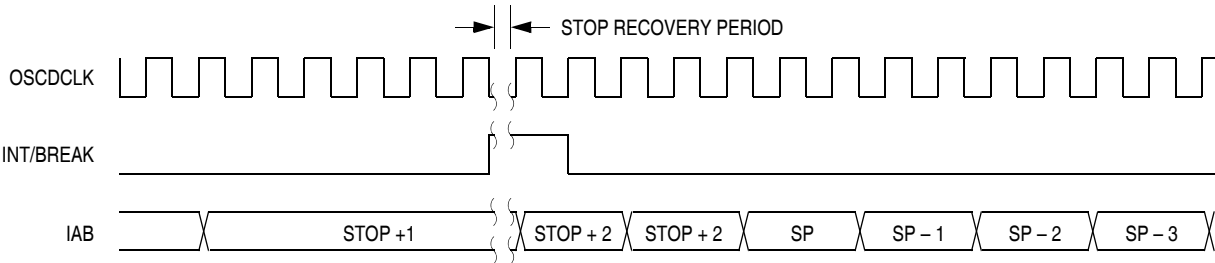


Figure 8-18. Stop Mode Recovery from Interrupt or Break

Section 9. Monitor ROM (MON)

9.1 Contents

9.2	Introduction	123
9.3	Features	124
9.4	Functional Description	124
9.4.1	Entering Monitor Mode	126
9.4.2	Data Format	129
9.4.3	Break Signal	129
9.4.4	Baud Rate	129
9.4.5	Commands	130
9.5	Security	135
9.5.1	Extended Security	136

9.2 Introduction

This section describes the monitor ROM (MON) and the monitor mode entry methods. The monitor ROM allows complete testing of the MCU through a single-wire interface with host computer. This mode is also used for programming and erasing of FLASH memory in the MCU. Monitor mode entry can be achieved without use of the higher voltage, V_{TST} , as long as vector addresses \$FFFE and \$FFFF are blank, thus reducing the hardware requirements for in-circuit programming.

9.4.1 Entering Monitor Mode

Table 9-1 shows the pin conditions for entering monitor mode. As specified in the table, monitor mode may be entered after a POR and will allow communication at 19200 baud provided one of the following sets of conditions is met:

1. If $\overline{\text{IRQ}} = V_{\text{TST}}$:
 - External clock on OSC1 is 12 MHz
 - PTA3 = high
 - PTE3 = high
2. If \$FFFE & \$FFFF is blank (contains \$FF):
 - External clock on OSC1 is 12 MHz
 - $\overline{\text{IRQ}} = V_{\text{DD}}$
 - PTE3 = high

Table 9-1. Mode Entry Requirements and Options

$\overline{\text{IRQ}}$	\$FFFE and \$FFFF	PTE3	PTA3 ⁽¹⁾	PTA2	PTA1	PTA0	External Clock, f_{XCLK}	Bus Frequency, f_{BUS}	Comments
V_{TST} ⁽²⁾	X	1	0	0	1	1	12 MHz	12 MHz (f_{XCLK})	High-voltage entry to monitor mode. 38400 baud communication on PTA0. COP disabled.
V_{TST} ⁽²⁾	X	1	1	0	1	1	12 MHz	6 MHz ($f_{\text{XCLK}} \div 2$)	High-voltage entry to monitor mode. 19200 baud communication on PTA0. COP disabled.
V_{DD}	BLANK (contain \$FF)	1	X	X	X	1	12 MHz	6 MHz ($f_{\text{XCLK}} \div 2$)	Low-voltage entry to monitor mode. 19200 baud communication on PTA0. COP disabled.
V_{DD}	NOT BLANK	1	X	X	X	X	12 MHz	6 MHz ($f_{\text{XCLK}} \div 2$)	Enters user mode. If \$FFFE and \$FFFF is blank, MCU will encounter an illegal address reset.

Notes:

1. PTA3 = 0: Bypasses the divide-by-two prescaler to SIM when using V_{TST} for monitor mode entry.
2. See [Section 20. Electrical Specifications](#) for V_{TST} voltage level requirements.

Section 10. Timer Interface Module (TIM)

10.1 Contents

10.2	Introduction	138
10.3	Features	138
10.4	Pin Name Conventions	139
10.5	Functional Description	139
10.5.1	TIM Counter Prescaler	143
10.5.2	Input Capture	143
10.5.3	Output Compare	144
10.5.3.1	Unbuffered Output Compare	144
10.5.3.2	Buffered Output Compare	145
10.5.4	Pulse Width Modulation (PWM)	145
10.5.4.1	Unbuffered PWM Signal Generation	146
10.5.4.2	Buffered PWM Signal Generation	147
10.5.4.3	PWM Initialization	148
10.6	Interrupts	149
10.7	Low-Power Modes	149
10.7.1	Wait Mode	150
10.7.2	Stop Mode	150
10.8	TIM During Break Interrupts	150
10.9	I/O Signals	151
10.9.1	TIM Clock Pin (PTE0/TCLK)	151
10.9.2	TIM Channel I/O Pins (PTE1/T1CH01:PTE2/T2CH01)	151
10.10	I/O Registers	152
10.10.1	TIM Status and Control Register	152
10.10.2	TIM Counter Registers	154
10.10.3	TIM Counter Modulo Registers	155
10.10.4	TIM Channel Status and Control Registers	156
10.10.5	TIM Channel Registers	159

10.4 Pin Name Conventions

The text that follows describes both timers, TIM1 and TIM2. The TIM input/output (I/O) pin names are T[1,2]CH01 (timer channel 01), where “1” is used to indicate TIM1 and “2” is used to indicate TIM2. The two TIMs share two I/O pins with two I/O port pins. The full names of the TIM I/O pins are listed in [Table 10-1](#). The generic pin names appear in the text that follows.

Table 10-1. Pin Name Conventions

TIM Generic Pin Names:		T[1,2]CH01	TCLK
Full TIM Pin Names:	TIM1	PTE1/T1CH01	PTE0/TCLK
	TIM2	PTE2/T2CH01	

NOTE: *References to either timer 1 or timer 2 may be made in the following text by omitting the timer number. For example, TCH01 may refer generically to T1CH01 and T2CH01.*

10.5 Functional Description

[Figure 10-1](#) shows the structure of the TIM. The central component of the TIM is the 16-bit TIM counter that can operate as a free-running counter or a modulo up-counter. The TIM counter provides the timing reference for the input capture and output compare functions. The TIM counter modulo registers, TMODH:TMODL, control the modulo value of the TIM counter. Software can read the TIM counter value at any time without affecting the counting sequence.

Channel 0 and channel 1 I/Os are connected together, forming a common I/O. Although the two TIM channels are programmable independently as input capture channels, the input capture signal will be the same for both channels. Output compare functions should only be enabled for one channel to avoid I/O contention.

Timer Interface Module (TIM)

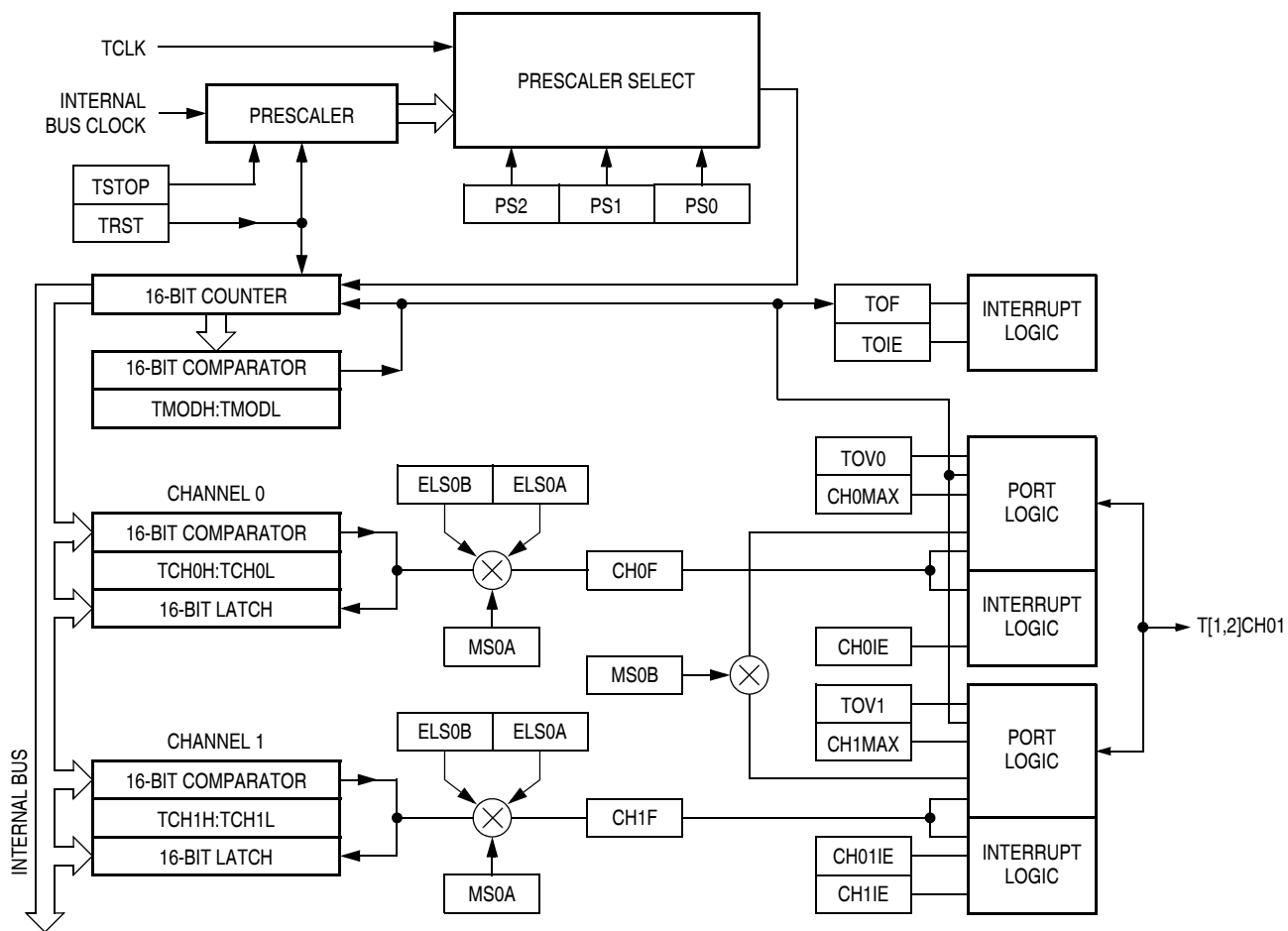


Figure 10-1. TIM Block Diagram

Figure 10-2 summarizes the timer registers.

NOTE: References to either timer 1 or timer 2 may be made in the following text by omitting the timer number. For example, TSC may generically refer to both T1SC and T2SC.

The value in the TIM counter modulo registers and the selected prescaler output determines the frequency of the PWM output. The frequency of an 8-bit PWM signal is variable in 256 increments. Writing \$00FF (255) to the TIM counter modulo registers produces a PWM period of 256 times the internal bus clock period if the prescaler select value is \$000. See [10.10.1 TIM Status and Control Register](#).

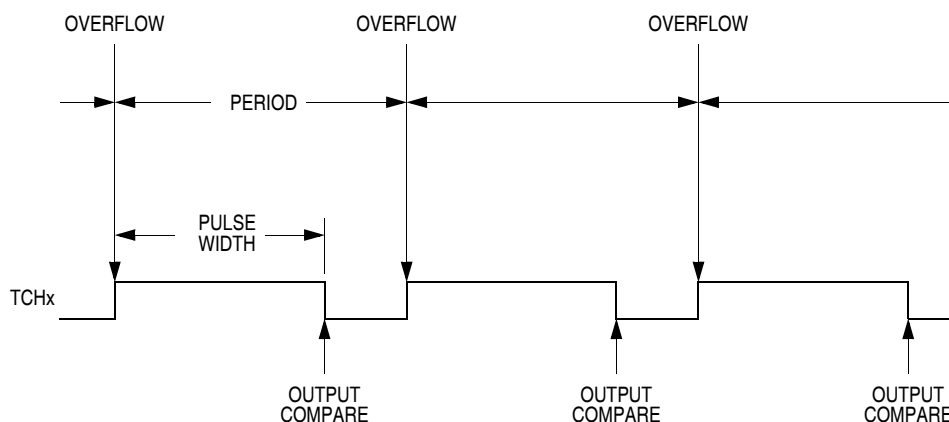


Figure 10-3. PWM Period and Pulse Width

The value in the TIM channel registers determines the pulse width of the PWM output. The pulse width of an 8-bit PWM signal is variable in 256 increments. Writing \$0080 (128) to the TIM channel registers produces a duty cycle of 128/256 or 50%.

10.5.4.1 Unbuffered PWM Signal Generation

Any output compare channel can generate unbuffered PWM pulses as described in [10.5.4 Pulse Width Modulation \(PWM\)](#). The pulses are unbuffered because changing the pulse width requires writing the new pulse width value over the old value currently in the TIM channel registers.

An unsynchronized write to the TIM channel registers to change a pulse width value could cause incorrect operation for up to two PWM periods. For example, writing a new value before the counter reaches the old value but after the counter reaches the new value prevents any compare during that PWM period. Also, using a TIM overflow interrupt routine to write a new, smaller pulse width value may cause the compare to be missed. The TIM may pass the new value before it is written.

Section 11. Universal Serial Bus Module (USB)

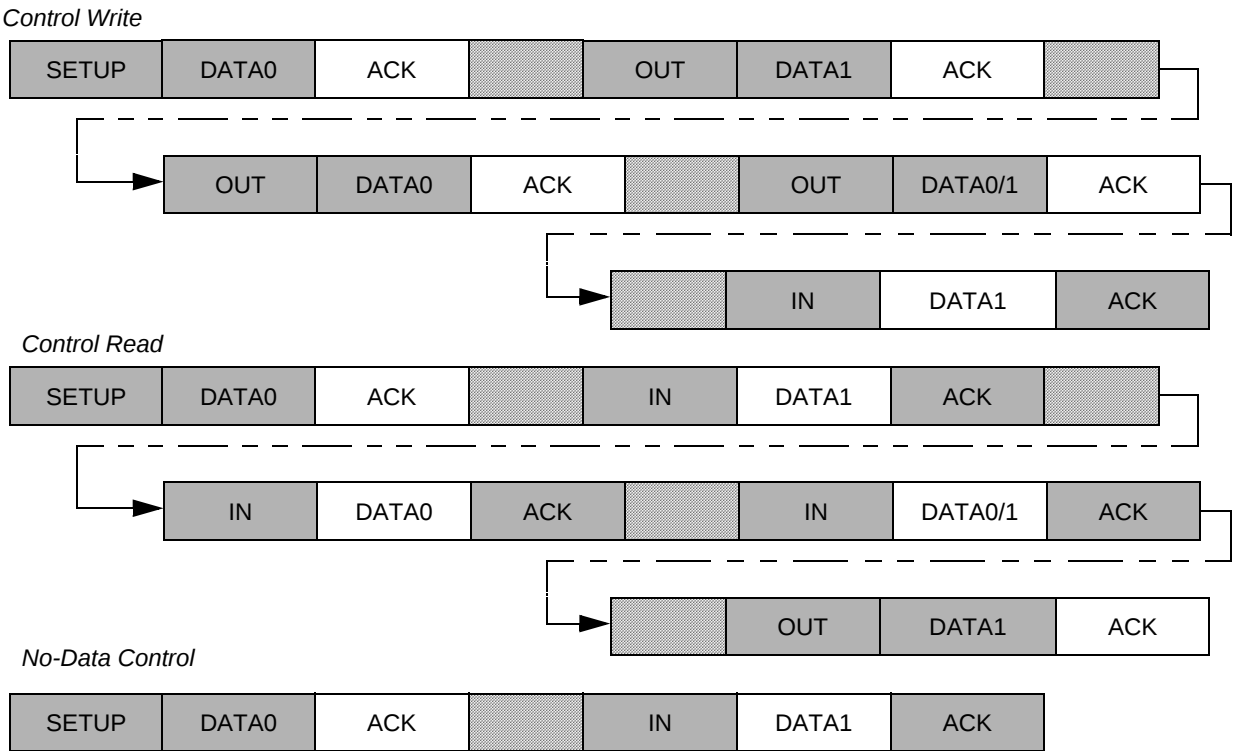
11.1 Contents

11.2	Introduction	162
11.3	Features	163
11.4	Pin Name Conventions	164
11.5	Functional Description	168
11.5.1	USB Protocol	169
11.5.1.1	Sync Pattern	170
11.5.1.2	Packet Identifier Field	171
11.5.1.3	Address Field (ADDR)	172
11.5.1.4	Endpoint Field (ENDP)	172
11.5.1.5	Cyclic Redundancy Check (CRC)	172
11.5.1.6	End-of-Packet (EOP)	172
11.5.2	Reset Signaling	173
11.5.3	Suspend	174
11.5.4	Resume After Suspend	175
11.5.4.1	Host Initiated Resume	175
11.5.4.2	USB Reset Signalling	175
11.5.4.3	Remote Wakeup	175
11.5.5	Low-Speed Device	176
11.6	Clock Requirements	176
11.7	Hardware Description	177
11.7.1	Voltage Regulator	177
11.7.2	USB Transceiver	177
11.7.2.1	Output Driver Characteristics	178
11.7.2.2	Low Speed (1.5 Mbps) Driver Characteristics	178
11.7.2.3	Receiver Data Jitter	179
11.7.2.4	Data Source Jitter	179
11.7.2.5	Data Signal Rise and Fall Time	180

11.5.1 USB Protocol

Figure 11-3 shows the various transaction types supported by the USB module. The transactions are portrayed as error free. The effect of errors in the data flow are discussed later.

ENDPOINT 0 TRANSACTIONS:



ENDPOINTS 1 & 2 TRANSACTIONS:

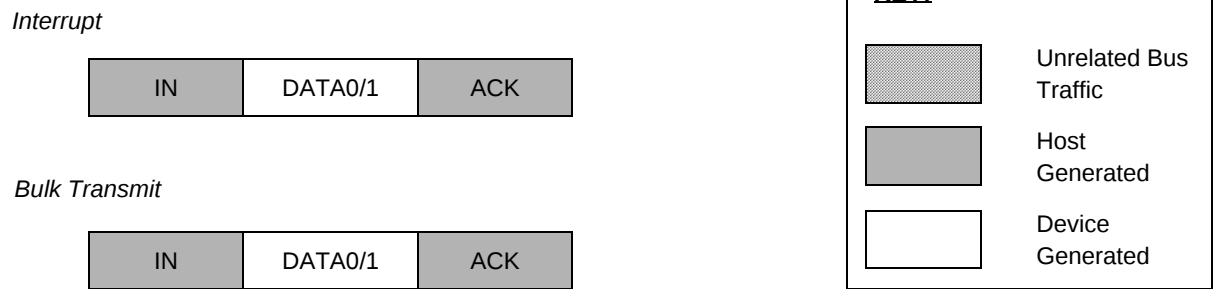


Figure 11-3. Supported Transaction Types Per Endpoint

11.8.12 USB Endpoint 0 Data Registers

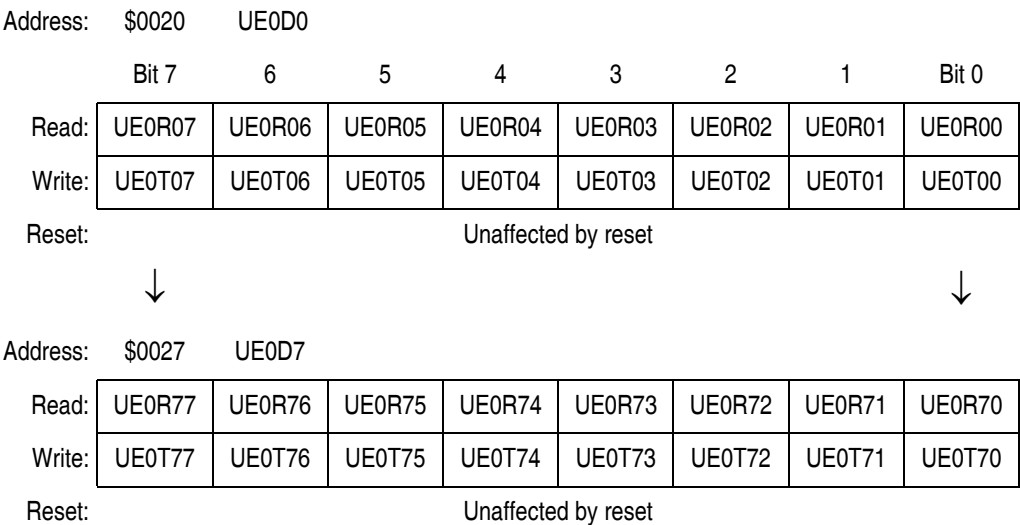


Figure 11-26. USB Endpoint 0 Data Registers (UE0D0–UE0D7)

UE0Rx7–UE0Rx0 — Endpoint 0 Receive Data Buffer

These read-only bits are serially loaded with OUT token or SETUP token data directed at endpoint 0. The data is received over the USB’s D+ and D– pins.

UE0Tx7–UE0Tx0 — Endpoint 0 Transmit Data Buffer

These write-only buffers are loaded by software with data to be sent on the USB bus on the next IN token directed at endpoint 0.

11.9 USB Interrupts

The USB module is capable of generating interrupts and causing the CPU to execute the USB interrupt service routine. There are three types of USB interrupts:

- End-of-transaction interrupts signify either a completed transaction receive or transmit transaction.
- Resume interrupts signify that the USB bus is reactivated after having been suspended.
- End-of-packet interrupts signify that a low-speed end-of-packet signal was detected.

All USB interrupts share the same interrupt vector. Firmware is responsible for determining which interrupt is active.

11.9.1 USB End-of-Transaction Interrupt

There are five possible end-of-transaction interrupts:

- Endpoint 0 or 2 receive
- Endpoint 0, 1 or 2 transmit

End-of-transaction interrupts occur as detailed in the following sections.

- Framing error (FE) — The FE bit in SCS1 is set when a logic 0 occurs where the receiver expects a stop bit. The framing error interrupt enable bit, FEIE, in SCC3 enables FE to generate SCI error CPU interrupt requests.
- Parity error (PE) — The PE bit in SCS1 is set when the SCI detects a parity error in incoming data. The parity error interrupt enable bit, PEIE, in SCC3 enables PE to generate SCI error CPU interrupt requests.

12.6 Low-Power Modes

The WAIT and STOP instructions put the MCU in low power-consumption standby modes.

12.6.1 Wait Mode

The SCI module remains active after the execution of a WAIT instruction. In wait mode, the SCI module registers are not accessible by the CPU. Any enabled CPU interrupt request from the SCI module can bring the MCU out of wait mode.

If SCI module functions are not required during wait mode, reduce power consumption by disabling the module before executing the WAIT instruction.

Refer to [8.7 Low-Power Modes](#) for information on exiting wait mode.

12.6.2 Stop Mode

The SCI module is inactive after the execution of a STOP instruction. The STOP instruction does not affect SCI register states. SCI module operation resumes after an external interrupt.

Because the internal clock is inactive during stop mode, entering stop mode during an SCI transmission or reception results in invalid data.

Refer to [8.7 Low-Power Modes](#) for information on exiting stop mode.

Address: \$005A

	Bit 7	6	5	4	3	2	1	Bit 0
Read:	LOOPS	ENSCI	TXINV	M	WAKE	ILTY	PEN	PTY
Write:								
Reset:	0	0	0	0	0	0	0	0

Figure 12-9. SCI Control Register 1 (SCC1)

LOOPS — Loop Mode Select Bit

This read/write bit enables loop mode operation. In loop mode the RxD pin is disconnected from the SCI, and the transmitter output goes into the receiver input. Both the transmitter and the receiver must be enabled to use loop mode. Reset clears the LOOPS bit.

1 = Loop mode enabled

0 = Normal operation enabled

ENSCI — Enable SCI Bit

This read/write bit enables the SCI and the SCI baud rate generator. Clearing ENSCI sets the SCTE and TC bits in SCI status register 1 and disables transmitter interrupts. Reset clears the ENSCI bit.

1 = SCI enabled

0 = SCI disabled

TXINV — Transmit Inversion Bit

This read/write bit reverses the polarity of transmitted data. Reset clears the TXINV bit.

1 = Transmitter output inverted

0 = Transmitter output not inverted

NOTE: *Setting the TXINV bit inverts all transmitted values, including idle, break, start, and stop bits.*

14.4 Port C

Port C is a 2-bit special function port that shares its pins with the serial communications interface (SCI) module. These pins have software configurable pullups.

14.4.1 Port C Data Register

The port C data register contains a data latch for each of the two port C pins.

Address: \$0002

	Bit 7	6	5	4	3	2	1	Bit 0
Read:	0	0	0	0	0	0	PTC1	PTC0
Write:								
Reset:	Unaffected by reset							
Alternative Function:							RxD	TxD
Additional Function:							Optional pullup	Optional pullup

Figure 14-5. Port C Data Register (PTC)

PTC[1:0] — Port C Data Bits

These read/write bits are software-programmable. Data direction of each port C pin is under the control of the corresponding bit in data direction register C. Reset has no effect on port C data.

The port C pullup enable bit, PCP, in the port option control register (POCR) enables pullups on PTC[1:0] if the respective pin is configured as an input. (See [14.7 Port Options](#).)

TxD, RxD — SCI Data I/O Pins

The TxD and RxD pins are the transmit data output and receive data input for the SCI module. The SCI enable bit, ENSCI, in the SCI control register 1 enables the PTC0/TxD and PTC1/RxD pins as SCI TxD and RxD pins and overrides any control from the port I/O. See [Section 12. Serial Communications Interface Module \(SCI\)](#).

Section 15. External Interrupt (IRQ)

15.1 Contents

15.2	Introduction	281
15.3	Features	281
15.4	Functional Description	282
15.5	$\overline{\text{IRQ}}$ Pin	284
15.6	PTE4/D– Pin	285
15.7	IRQ Module During Break Interrupts	285
15.8	IRQ Status and Control Register	286
15.9	IRQ Option Control Register	287

15.2 Introduction

The IRQ module provides two external interrupt inputs: one dedicated $\overline{\text{IRQ}}$ pin and one shared port pin, PTE4/D–.

15.3 Features

Features of the IRQ module include:

- Two external interrupt pins, $\overline{\text{IRQ}}$ and PTE4/D–
- $\overline{\text{IRQ}}$ interrupt control bits
- Hysteresis buffer
- Programmable edge-only or edge and level interrupt sensitivity
- Automatic interrupt acknowledge
- Low leakage $\overline{\text{IRQ}}$ pin for external RC wake up input
- Selectable internal pullup resistor

20.4 Functional Operating Range

Characteristic	Symbol	Value	Unit
Operating temperature range	T_A	0 to 70	°C
Operating voltage range	V_{DD}	4.0 to 5.5	V

20.5 Thermal Characteristics

Characteristic	Symbol	Value	Unit
Thermal Resistance LQFP (32 pins) SOIC (28 pins)	θ_{JA}	95 70	°C/W
I/O pin power dissipation	$P_{I/O}$	User-Determined	W
Power dissipation ⁽¹⁾	P_D	$P_D = (I_{DD} \times V_{DD}) + (I_{DDA} \times V_{DDA}) + P_{I/O} = K/(T_J + 273 \text{ °C})$	W
Constant ⁽²⁾	K	$P_D \times (T_A + 273 \text{ °C}) + P_D^2 \times \theta_{JA}$	W/°C
Average junction temperature	T_J	$T_A + (P_D \times \theta_{JA})$	°C
Maximum junction temperature	T_{JM}	100	°C

Notes:

- Power dissipation is a function of temperature.
- K is a constant unique to the device. K can be determined for a known T_A and measure P_D . With this value of K, P_D and T_J can be determined for any value of T_A .

20.9 Timer Interface Module Characteristics

Characteristic	Symbol	Min	Max	Unit
Input capture pulse width	t_{TIH}, t_{TIL}	$1/f_{OP}$	—	ns
Input clock pulse width	t_{TCH}, t_{TCL}	$(1/f_{OP}) + 5$	—	ns

20.10 USB DC Electrical Characteristics

Characteristic ⁽¹⁾	Symbol	Conditions	Min	Typ	Max	Unit
Hi-Z state data line leakage	I_{LO}	$0 V < V_{IN} < 3.3 V$	−10		+10	μA
Voltage input high (driven)	V_{IH}		2.0			V
Voltage input high (floating)	V_{IHZ}		2.7		3.6	V
Voltage input low	V_{IL}				0.8	V
Differential input sensitivity	V_{DI}	$ (D+) - (D-) $	0.2			V
Differential common mode range	V_{CM}	Includes V_{DI} Range	0.8		2.5	V
Static output low	V_{OL}	R_L of 1.425 K to 3.6 V			0.3	V
Static output high	V_{OH}	R_L of 14.25 K to GND	2.8		3.6	V
Output signal crossover voltage	V_{CRS}		1.3	—	2.0	V
Regulator bypass capacitor	$C_{REGBYPASS}$			0.1		μF
Regulator bulk capacitor	$C_{REGBULK}$		4.7			μF

Notes:

1. $V_{DD} = 4.0$ to 5.5 Vdc, $V_{SS} = 0$ Vdc, $T_A = T_L$ to T_H , unless otherwise noted.

21.3 32-Pin Low-Profile Quad Flat Pack (LQFP)

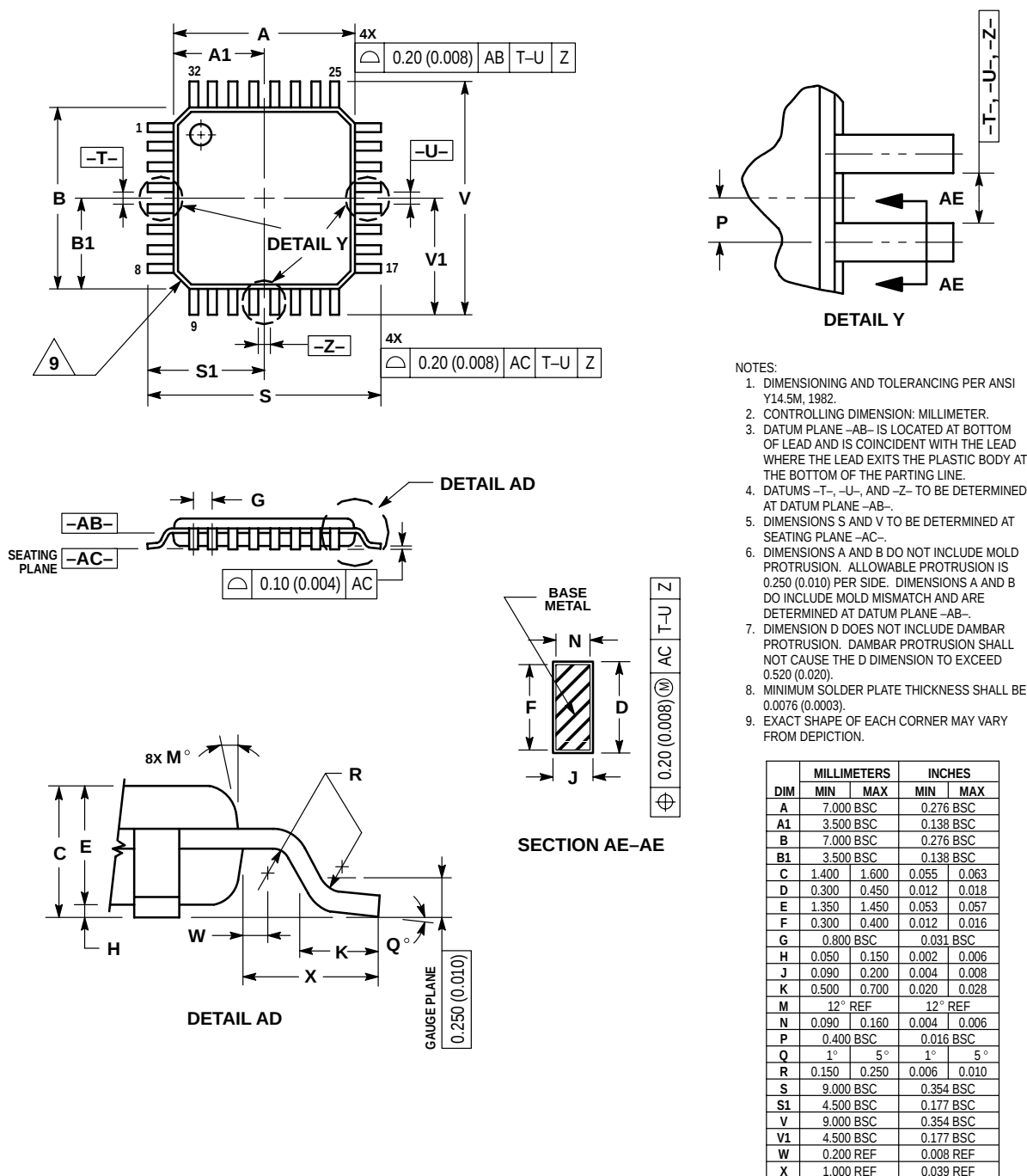


Figure 21-1. 32-Pin LQFP (Case #873A)